

Notice of References Cited	Application/Control No. 10/606,699	Applicant(s)/Patent Under Reexamination MEIRI ET AL.	
	Examiner Yaima Campos	Art Unit 2185	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,901,327	05-1999	Ofek, Yuval	710/5
*	B	US-6,880,045	04-2005	Pong et al.	711/135
*	C	US-6,012,063	01-2000	Bodnar, Eric O.	707/101
*	D	US-6,687,801	02-2004	Kamvysselis, Peter	711/162
*	E	US-6,553,464	04-2003	Kamvysselis et al.	711/148
*	F	US-6,609,183	08-2003	Ohran, Richard S.	711/161
*	G	US-6,615,320	09-2003	Arimilli et al.	711/141
*	H	US-2004/0034754	02-2004	Schreiber, Robert S.	711/165
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.